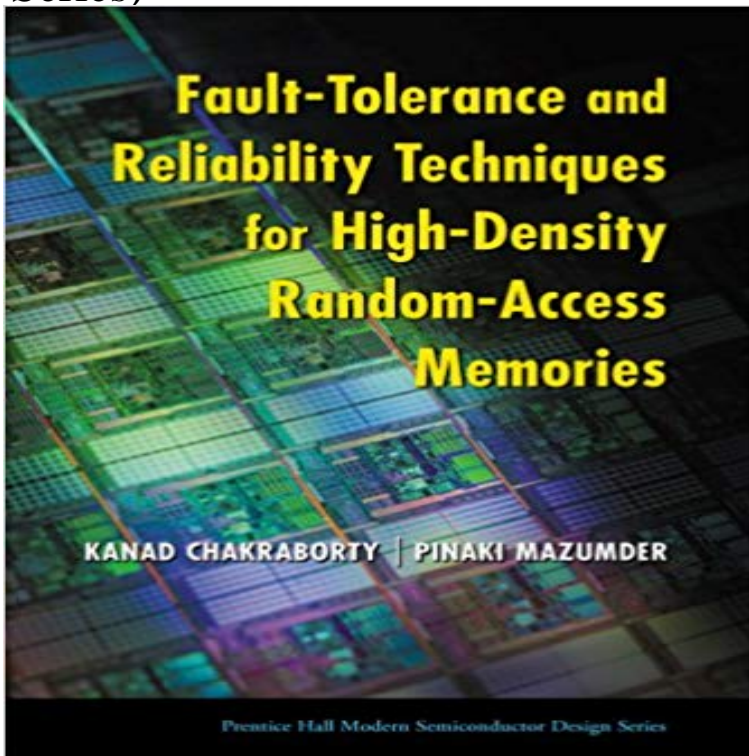


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are being used for increasing the memory testability and for